

<b>Notice of References Cited</b>			Application/Control No.	Applicant(s)/Patent Under Reexamination WEISS ET AL.	
			Examiner Eric S. McCall	Art Unit 2855	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0129249	07-2004	Kondo, Wakichi	123/346
	B	US-2003/0230281	12-2003	Hoshino, Masato	123/406.29
	C	US-2003/0230280	12-2003	Allston et al.	123/403
	D	US-6,408,685	06-2002	Shin, Dalheun	73/116
	E	US-6,288,409	09-2001	Maier et al.	250/559.4
	F	US-5,921,219	07-1999	Frohlich et al.	123/399
	G	US-5,775,355	07-1998	Maier et al.	137/1
	H	US-5,641,891	06-1997	Frankl et al.	73/1.72
	I	US-4,957,074	09-1990	Weissler et al.	123/90.11
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.